

In Place of FORM PTO-1449 (Modified)

Serial No. 10/670,824

**LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT**

Applicant: Brokenshire

Filing Date: 9/25/2003

Group:

Atty. Docket No. AUS920030702US1

U. S. PATENT DOCUMENTS

<u>Examiner Initial</u>	<u>Document Number</u>	<u>Date</u>	<u>Name</u>	<u>Classification Class / Subclass</u>	<u>Filing Date if Appropriate</u>
_____	AA				
_____	AB				
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FOREIGN PATENT DOCUMENTS

<u>Examiner Initial</u>		<u>Document Number</u>	<u>Date</u>	<u>Country</u>	<u>Classification</u>	<u>Translation Yes No</u>
<u>PN</u>	AH	JP2002-366534	12-2002	Japan	G06F 15/177	abstract only
<u>PN</u>	AI	JP05-242057	09-1993	Japan	G06F 15/16	abstract only
<u>PN</u>	AJ	JP10-269165	10-1998	Japan	G06F 13/16	abstract only
<u>PN</u>	AK	JP08-095757	04-1996	Japan	G06F 9/06	abstract only
<u>PN</u>	AL	JP2002-342165	11-2002	Japan	G06F 12/14	abstract only
<u>PN</u>	AM	JP2003-140912	05-2003	Japan	G06F 9/54	abstract only
<u>PN</u>	AN	JP08-147171	06-1996	Japan	G06F 9/445	abstract only
<u>PN</u>	AO	JP06-044110	02-1994	Japan	G06F 12/00	abstract only

Examiner
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner: /Phillip Nguyen/

Date Considered: 02/09/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<u>PN</u>	AA	4,787,057	11-1998	Hammond	708/607	
<u>PN</u>	AB	5,548,798	08-1996	King	710/68	
	AC					
	AD					

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<u>PN</u>	AA	2003/0074650	04-2003	Akgul et al.	717/129	
<u>PN</u>	AB	6,480,818	11-2002	Alverson et al.	703/26	

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<u>PN</u>	AA	5,887,186	03-1999	Nakanishi	712/28	
<u>PN</u>	AB	5,490,278	02-1996	Mochizuki	708/446	

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PN	AA	6,526,491	02-2003	Suzuoki et al.	711 / 164	
PN	AB	6,128,724	10-2000	Lee et al.	712 / 32	
PN	AC	6,381,659	04-2002	Proch et al.	710 / 57	
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<u>PN</u>	AA	2003/0055984	Jul. 18, 2002	Shimakawa et al.	709	316	Oct. 12, 2001
<u>PN</u>	AB	2002/0156993	Oct. 24, 2002	Suzuoki et al.	712	30	Mar 22, 2001
<u>PN</u>	AC	2002/0138707	Sep 26, 2002	Suzuoki et al.	711	163	Mar 22, 2001
<u>PN</u>	AD	2002/0138701	Sep 26, 2002	Suzuoki et al.	711	154	Mar 22, 2001
<u>PN</u>	AE	2002/0138637	Sep 26, 2002	Suzuoki et al.	709	230	Mar 22, 2001
<u>PN</u>	AF	2002/0135582	Sep 26, 2002	Suzuoki et al.	345	502	Mar 22, 2001
<u>PN</u>	AG	2002/0095523	Jul. 18, 2002	Shimakawa et al.	709	316	Oct. 12, 2001
<u>PN</u>	AH	2002/0060690	May 23, 2002	Tanaka et al.	345	619	Mar. 1, 2001
<u>PN</u>	AI	2002/0046229	Apr. 18, 2002	Yutaka et al.	709	102	Mar. 2, 2001
<u>PN</u>	AJ	6,559,854	May 6, 2003	Oka et al.	345	619	Mar. 1, 2001
<u>PN</u>	AK	2001/0002130	May 31, 2001	Suzuoki	345	420	Dec 15, 2000
<u>PN</u>	AL	6,526,491	Feb. 25, 2003	Suzuoki et al.	711	164	Mar 22, 2001

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